

FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office				Attorney Docket Number 5308-390			Serial No. 10/815,293
LIST OF DOCUMENTS CITED BY APPLICANT				Applicant: Matthew Donofrio			
				Filing Date: April 1, 2004		Group: 2814	
U. S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
AC	1	6,504,180 B1	1/7/03	Heremans et al.	257	98	
	2	6,483,196 B1	11/19/02	Wojnarowski et al.	257	778	
	3	6,410,348 B1	6/25/02	Chen et al.	438	9	
	4	5,210,766	5/11/93	Winer et al.	372	40	
AC	5	2005/0227379A1	10/13/05	Donofrio	438	4	
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
AC	6	EP 1 263 058 A2	5/29/05	Europe	H01L	33/00	
AC	7	WO 2005/104253 A1	11/3/05	PCT	H01L	33/00	
AC	8	WO 02/073705 A2	9/19/02	PCT	H01L	33/00	
	9	WO 02/41362 A2	5/23/02	PCT	H01L		
AC	10	WO 02/041362 A2	5/23/02	PCT	H01L		
AC	11	WO 02/041362 A3	5/23/02	PCT	B23K	26/38	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							
AC	12	Pan et al. "Improvement of InGaN-GaN Light-Emitting Diodes with Surface-Textured Indium-Tin-Oxide Transparent Ohmic Contacts," <i>IEEE Photonics Technology Letters</i> , Vol. 15, No. 5, May 2003.					
AC	13	Shafeev et al. "Uncongruent laser ablation and electroless metallization of SiC," <i>Applied Physics Letters</i> , Vol. 68, No. 6, February 5, 1996.					
AC	14	International Search Report and Written Opinion of the International Searching Authority for corresponding PCT application no. PCT/US2005/001933, issued 7/19/06.					

EXAMINER
*EXAMINER*Alonso Chambles*

DATE CONSIDERED

7/16/06

Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.